Remarks

Applicant gratefully acknowledges the helpful suggestions provided by the Examiner. In accordance with those suggestions claims 58 and 69 have been amended to recite microelectromechanical devices, and claims 59 and 70 have been amended to replace "miniature electromechanical" with --microelectromechanical--. As noted by the Examiner, the accepted nomenclature for MEMS is microelectromechanical system.

In like manner, on page 3 of the specification in the paragraph of the "Detailed Description of the Invention," the paragraph has been amended to replace "miniature electromechanical" with --microelectromechanical--. Support for this amendment may be found in *An Introduction to Microelectromechanical Systems Engineering*, pp. xvi, Nadim Maluf, Norwood, MA, Artech House, 2000, a copy of which is enclosed.

Claim 62 has been amended to limit the metals melted on the contact pads to metals selected from a group consisting of aluminum, copper, gold, silver and alloys comprising these metals. Support for this amendment may be found in the specification, page 7, lines 14-23.

Claim 62 was rejected over Mackay et al., U.S. Patent 6,293,451. Mackay et al. describe forming solder balls on contact pads, melting the solder which cools to spherical shapes on the contact pads and there is no teaching or suggestion in Mackay et al. to use aluminum, copper, gold, silver and their alloys. Chen et al., U.S. Patent 6,063,647, col. 4, lines 13-23 and 44-48, describe circuit elements of dielectrics that support a circuit network. The circuit elements include flexible circuits, printed circuit boards, chips, and dies, and are typically polyimide foil. Chen et al. col. 5, lines 26-29, suggest as metal for the bumps tin, aluminum, indium, lead, gold, silver, bismuth, copper, palladium and the like and alloys of these materials. The melting points of

aluminum, gold, silver, copper and palladium are 659°C, 1063°C, 961°C, 1083°C and 1555°C respectively. Heating the substrates, i.e. circuit elements, of Chen et al. to these temperatures in order to melt these metals and form bumps would destroy the substrates. Therefore applicant respectfully submits that Chen et al. teach away from applicant's invention, and one of ordinary skill in the art would not attempt to modify the method of MacKay et al. and Capote et al. to form bumps of aluminum, copper, gold, silver and alloys comprising these metals.

Although Chen et al. prefer spherical-shaped bumps, other shapes are permissible, col.5, lines 11-14. The bumps of Chen et al. are formed on the circuit element by conventional deposition techniques, col. 5, line 25; Chen et al. are silent on methods of depositing the preferably spherical-shaped bumps. Therefore applicant respectfully submits that Chen et al. do not teach or suggest applicant's method of melting aluminum, copper, gold, silver or alloys of these metals to obtain convex bumps on the contact pads of insulating substrates.

Claim 63 was rejected over MacKay et al. who have described the solder as being deposited by electroplating. Claim 63, dependent on amended claim 62, does not cover solder deposition, it is limited to depositing aluminum, copper, gold, silver or alloys of these metals. Therefore applicant respectfully request that the rejection of claims 63 over MacKay et al. be withdrawn.

Claims 66-68 have been amended to limit the metals deposited to form the protuberances to the group consisting of aluminum, copper, gold, silver or alloys of these metals. Claim 66 has also been amended to delete a typographical error, "a" at the end of line 11 of the claim. Claim 66 was rejected over MacKay et al. and Capote et al. Applicant respectfully submits that the

subject matter of claims 66-68 as now amended is not suggested by MacKay et al. and Capote et

al.

Claim 71 has been amended to depend on claim 65 so that is now covers

depositing copper by printing a paste of a copper powder in an organic vehicle; drying the

copper paste deposits; heating the copper paste deposits at a temperature sufficient to destroy the

organic vehicle, melting the copper deposits, whereupon melting, the copper deposits form

shapes of convex copper protuberances on the metallic contact pads, and then cooling the copper

protuberances. Support for this amendment may be found in the original specification on page

10, lines 4-10.

Claims 54-57, 60 and 61 previously had been allowed.

Applicant respectfully submits that claims 58, 59 and 62-71 as now amended describe

novel, useful manufacturing methods, and applicant respectfully requests early allowance.

Respectfully submitted

hn IM Carmack

John F. McCormack

Applicant's Agent Reg. No. 30474

John McComack 116 Milburn La

Roslyn Heights, NY 11577

Tel.: (516)621-7830

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An Introduction to Microelectromechanical Systems Engineering

Nadim Maluf



Artech House Boston • London

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Library of Congress Cataloging-in-Publication Data

Maluf, Nadim.

An introduction to microelectricomechanical systems enginnering

cm. — (Anech House MEMS library) / Nadim Maluf.

Includes bibliographical references and index. ISBN 0-89006-581-0 (alk. paper)

II. Series. 1. Title. 1. Microelectromechanical systems.

TK7875 .M35 2000

621.381—dc21

99-052406 G

British Library Cataloguing in Publication Data

Maluf, Nadim

An introduction to microelectromechanical systems -

(Arrech House MEMS library)

1. Microelectromechanical systems

621.3'81 I. Tille

ISBN 0-89006-581-0

Cover design by Lynda Fishbourne. Cover illustration by Jerry Gist.

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685 Canton Street

Norwood, MA 02062

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International Standard Book Number: 0-89006-581-0 Library of Congress Catalog Card Number: 99-18034

Preface

ing keen interest in learning about this emerging technology. This book is conference room was packed, and all ears were attentive. Everyone was in the audience were nodding in a sign of comprehension, the glazed managers, engineers, sclentists, and even engineering students with little or no previous experience in microelectromechanical systems are showeager to learn about this mysterious buzzword, "MBMS." Although many looks on their faces betrayed them. This experience is not unique, but one ogy is simply too broad to be explained in a short lecture. Many technical L explaining the merits of micromachining technology. The small that is repeated frequently in auditoriums around the world. The technolfew years ago I stood before an audience at a customer's facility written for those individuals.

In this book I sought to introduce the technology by describing basic labrication processes and select examples of devices and microsystems ing products in the near future—practical examples from the "real world." The objective is to provide a set of representative cases that can and a sense of its diversity. The text describes the basic operation and fabrication of many devices, along with packaging requirements. Inspired by the adage "a picture is worth a thousand words," I have included numerous descriptive schematic illustrations. It is my hope that scanning these that are either commercially available, or show great promise of becomgive the reader a global understanding of the technology's foundations.